

Notice of References Cited	Application/Control No. 10/734,136		Applicant(s)/Patent Under Reexamination HAN, IN-TAEK	
	Examiner Anne M. Hines		Art Unit 2879	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,897,319	01-1990	Sun, Sey-Shing	428/690
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FOREIGN PATENT DOCUMENTS

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